

## **Contents**

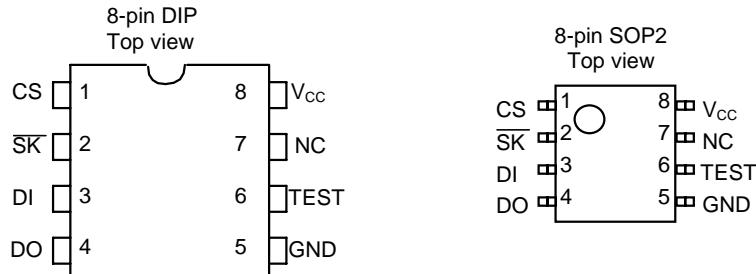
Features.....	1
Pin Assignment.....	1
Pin Functions .....	1
Block Diagram.....	2
Instruction Set.....	2
Absolute Maximum Ratings.....	2
Recommended Operating Conditions .....	3
Pin Capacitance.....	3
Endurance.....	3
DC Electrical Characteristics.....	4
AC Electrical Characteristics .....	5
Operation .....	6
Receiving a Start-Bit .....	8
Three-wire Interface (DI-DO direct connection)...	8
Connecting to the CPU with Serial Port.....	9
Dimensions (Unit:mm).....	10
Ordering Information .....	11
Characteristics .....	12

The S-29590A / 690A series are low power 16K / 32K-bit E<sup>2</sup>PROM with a low operating voltage range. They are organized as 1024-word×16-bit and 2048-word×16bit, respectively. Each is capable of sequential read, at which time addresses are automatically incremented in 16-bit blocks. Interface is structured so that this IC can be directly connected to the CPU with serial ports. 8-bit instructions make it easy to prepare your own software.

## ■ Features

- Low power consumption
  - Standby : 1.0µA Max.
  - Operating : 1.2 mA Max. (VCC=5.5 V)
  - : 0.4 mA Max. (VCC=2.5 V)
- Wide operating voltage range
  - Write : 1.8 to 5.5 V
  - Read : 1.8 to 5.5 V
- Sequential read capable
- Can be easily connected to the serial port
- Endurance : 10<sup>6</sup> cycles/word
- Data retention : 10 years

## ■ Pin Assignment



\* See ■ Dimensions

**Figure 1**

## ■ Pin Functions

**Table 1**

Name	Pin Number		Function
	SOP2	SSOP	
CS	1	1	Chip select input
SK	2	2	Serial clock input
DI	3	3	Serial data input
DO	4	4	Serial data output
GND	5	5	Ground
TEST	6	6	Test pin (normally kept open) (can be connected to GND or V <sub>cc</sub> )
NC	7	7	No Connection
V <sub>cc</sub>	8	8	Power supply

# CMOS SERIAL E<sup>2</sup>PROM S-29590A / 29690A

---

## ■ Block Diagram

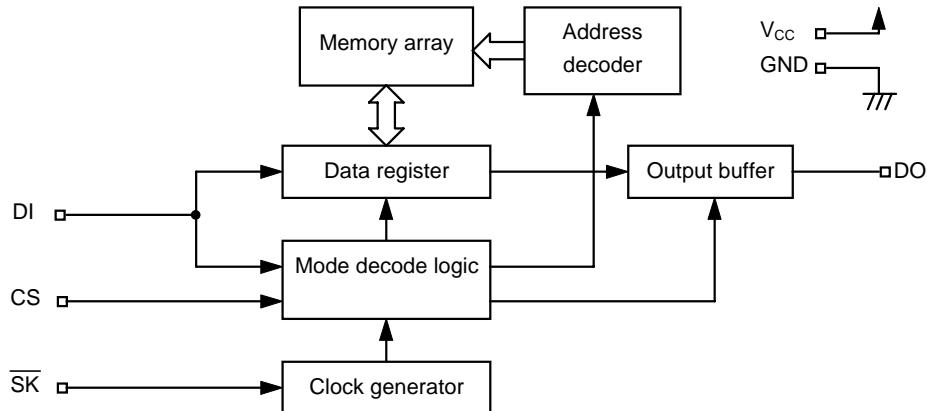


Figure 2

## ■ Instruction Set

Table 2

Instruction	Start Bit	Ope Code	Address		Data
			S-29530A	S-29630A	
READ (Read data)	1	1000	xA <sub>9</sub> to A <sub>0</sub>	A <sub>10</sub> to A <sub>0</sub>	D <sub>15</sub> to D <sub>0</sub> Output*
PROGRAM (Program data)	1	x100	xA <sub>9</sub> to A <sub>0</sub>	A <sub>10</sub> to A <sub>0</sub>	D <sub>15</sub> to D <sub>0</sub> Input
PEN (Program enable)	1	0011	xxxxxxxxxx	xxxxxxxxxx	—
PDS (Program disable)	1	0000	xxxxxxxxxx	xxxxxxxxxx	—

x : Doesn't matter.

\* : Addresses are continuously incremented.

## ■ Absolute Maximum Ratings

Table 3

Parameter	Symbol	Ratings	Unit
Power supply voltage	V <sub>CC</sub>	-0.3 to +7.0	V
Input voltage	V <sub>IN</sub>	-0.3 to V <sub>CC</sub> +0.3	V
Output voltage	V <sub>OUT</sub>	-0.3 to V <sub>CC</sub>	V
Storage temperature under bias	T <sub>bias</sub>	-50 to +95	°C
Storage temperature	T <sub>stg</sub>	-65 to +150	°C

■ Recommended Operating Conditions

**Table 4**

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Power supply voltage	V <sub>CC</sub>	READ/PROGRAM EWEN/EWDS	1.8	—	5.5	V
High level input voltage	V <sub>IH</sub>	V <sub>CC</sub> = 2.5 to 5.5 V	0.8×V <sub>CC</sub>	—	V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.8 to 2.5 V	0.8×V <sub>CC</sub>	—	V <sub>CC</sub>	V
Low level input voltage	V <sub>IL</sub>	V <sub>CC</sub> = 2.5 to 5.5 V	0.0	—	0.2×V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.8 to 2.5 V	0.0	—	0.15×V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>		- 40	—	+ 85	°C

■ Pin Capacitance

**Table 5**

(Ta=25 °C, f=1.0 MHz, V<sub>CC</sub>=5 V)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C <sub>IN</sub>	V <sub>IN</sub> =0 V	—	—	8	pF
Output Capacitance	C <sub>OUT</sub>	V <sub>OUT</sub> =0 V	—	—	10	pF

■ Endurance

**Table 6**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Endurance	N <sub>w</sub>	10 <sup>6</sup>	—	—	cycles/word

**CMOS SERIAL E<sup>2</sup>PROM  
S-29590A / 29690A**

---

■ DC Electrical Characteristics

**Table 7**

Parameter	Smb	Conditions	V <sub>CC</sub> =4.5 V to 5.5 V			V <sub>CC</sub> =2.5 V to 4.5 V			V <sub>CC</sub> =1.8 to 2.5 V			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Current consumption (READ)	I <sub>CC1</sub>	DO unloaded	—	—	1.2	—	—	0.6	—	—	0.4	mA
Current consumption (PROGRAM)	I <sub>CC2</sub>	DO unloaded	—	—	5.0	—	—	2.0	—	—	1.5	mA

**Table 8**

Parameter	Smb	Conditions	V <sub>CC</sub> =4.5 V to 5.5 V			V <sub>CC</sub> =2.5 to 4.5 V			V <sub>CC</sub> =1.8 to 2.5 V			Unit
			Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
Standby current consumption	I <sub>SB</sub>	CS=GND DO=Open Connected to V <sub>CC</sub> or GND	—	—	1.0	—	—	1.0	—	—	1.0	μA
Input leakage current	I <sub>LI</sub>	V <sub>IN</sub> =GND to V <sub>CC</sub>	—	0.1	1.0	—	0.1	1.0	—	0.1	1.0	μA
Output leakage current	I <sub>LO</sub>	V <sub>OUT</sub> =GND to V <sub>CC</sub>	—	0.1	1.0	—	0.1	1.0	—	0.1	1.0	μA
Low level output voltage	V <sub>OL</sub>	CMOS I <sub>OL</sub> = 100μA	—	—	0.1	—	—	0.1	—	—	—	V
High level output voltage	V <sub>OH</sub>	CMOS V <sub>CC</sub> =2.5 to 5.5V:I <sub>OH</sub> = -100μA V <sub>CC</sub> =1.8 to 2.5V:I <sub>OH</sub> = -10μA	V <sub>CC</sub> -0.7	—	—	V <sub>CC</sub> -0.7	—	—	V <sub>CC</sub> -0.3	—	—	V
Write enable latch data hold voltage	V <sub>DH</sub>	Only when write disable mode	1.5	—	—	1.5	—	—	1.5	—	—	V

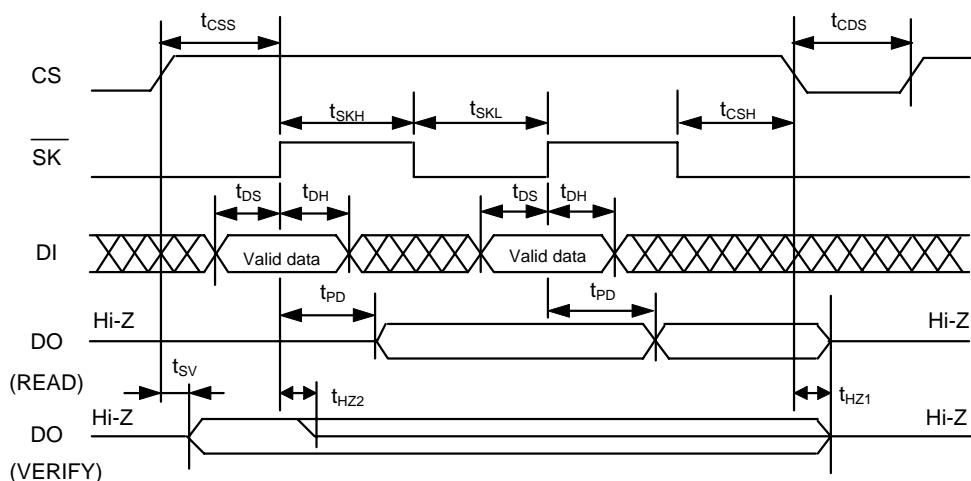
■ AC Electrical Characteristics

**Table 9**

Input pulse voltage	0.1×V <sub>CC</sub> to 0.9×V <sub>CC</sub>		
Output reference voltage	0.5×V <sub>CC</sub>		
Output load	100pF		

**Table 10**

Parameter	Symbol	V <sub>CC</sub> =4.5 to 5.5 V			V <sub>CC</sub> =2.5 to 4.5 V			V <sub>CC</sub> =1.8 to 2.5 V			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	
CS setup time	t <sub>CS</sub>	0.2	—	—	0.4	—	—	1.0	—	—	μs
CS hold time	t <sub>CSH</sub>	0.2	—	—	0.4	—	—	1.0	—	—	μs
CS deselect time	t <sub>CDS</sub>	0.2	—	—	0.2	—	—	0.4	—	—	μs
Data setup time	t <sub>DS</sub>	0.2	—	—	0.4	—	—	0.8	—	—	μs
Data hold time	t <sub>DH</sub>	0.2	—	—	0.4	—	—	0.8	—	—	μs
Output delay	t <sub>PD</sub>	—	—	0.5	—	—	1.0	—	—	2.0	μs
Clock frequency	f <sub>SK</sub>	0	—	1.4	0	—	0.5	0	—	0.2	MHz
Clock pulse width	t <sub>SKH</sub> , t <sub>SKL</sub>	0.35	—	—	1.0	—	—	2.5	—	—	μs
Output disable time	t <sub>HZ1</sub> , t <sub>HZ2</sub>	0	—	0.15	0	—	0.5	0	—	1.0	μs
Output enable time	t <sub>SV</sub>	0	—	0.15	0	—	0.5	0	—	1.0	μs
Programming time	t <sub>PR</sub>	—	4.0	10.0	—	4.0	10.0	—	4.0	10.0	ms



**Figure 3 Timing Chart**

# CMOS SERIAL E<sup>2</sup>PROM

## S-29590A / 29690A

### ■ Operation

Instructions (in the order of start-bit, instruction, address, and data) are latched to DI in synchronization with the rising edge of SK after CS goes high. A start-bit can only be recognized when the high of DI is latched to the rising edge of SK when CS goes from low to high, it is impossible for it to be recognized as long as DI is low, even if there are SK pulses after CS goes high. Instruction input finishes when CS goes low, where it must be low between commands during  $t_{CDS}$ .

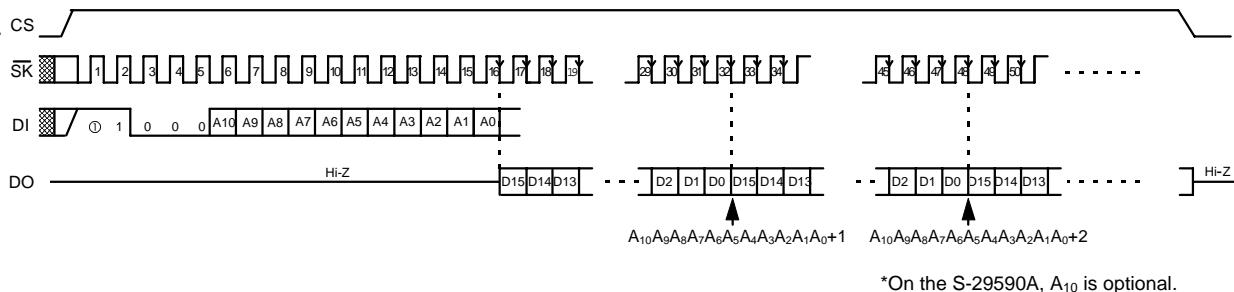
All input, including DI and SK signals, is ignored while CS is low, which is stand-by mode. The start bit + instruction, address and data are 8-bit instructions. This makes it easy to prepare your own software using a serial interface incorporated into the CPU.

#### 1. Read

The READ instruction reads data from a specified address. After A0 is latched at the rising edge of SK, 16-bit data is continuously output in synchronization with the falling edge of SK.

When all of the data (D15 to D0) in the specified address has been read, the data in the next address can be read with the input of another SK clock. Thus, it is possible for all of the data addresses to be read through the continuous input of SK clocks as long as CS is high.

The last address (An ... A1 A0 = 1 ... 11) rolls over to the top address (An ... A1 A0 = 0 ... 00).



**Figure 4** Read Timing (S-29690A)

## 2. Write (PROGRAM)

The PROGRAM instruction automatically begins writing to the non-volatile memory when CS goes low at the completion of the specified clock input.

The write operation is completed in 10 ms ( $t_{PR}$  Max.), and the typical write period is less than 4 ms. In the S-29590A / 690A series, it is easy to VERIFY the completion of the write operation in order to minimize the write cycle by setting CS to high and checking the DO pin, which is low during the write operation and high after its completion. This VERIFY procedure can be executed over and over again. There are two methods to detect a change in the DO output. One is to detect a change from low to high setting CS to high, and the other is to detect a change from low to high as a result of repetitious operations of returning the CS to low after setting CS to high and checking the DO output.

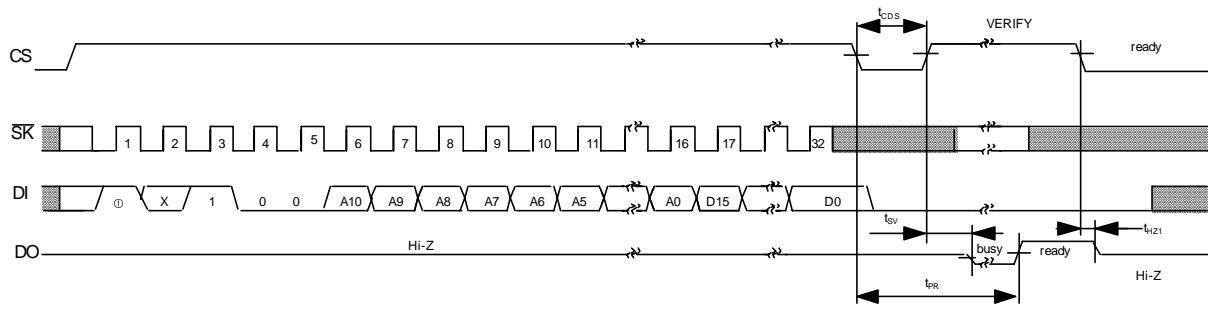
Because all  $\overline{SK}$  and DI inputs are ignored during the write operation, any input of instruction will also be disregarded. When DO outputs high after completion of the write operation or if it is in the high-impedance state (Hi-Z), the input of instructions is available. Even if the DO pin remains high, it will enter the high-impedance state upon the recognition of a high of DI (start-bit) attached to the rising edge of an  $\overline{SK}$  pulse. (see Figure 3).

DI input should be low during the VERIFY procedure.

### 2.1 PROGRAM

This instruction writes 16-bit data to a specified address.

After changing CS to high, input a start-bit, op-code (PROGRAM), address, and 16-bit data. If there is a data overflow of more than 16 bits, only the last 16-bits of the data is considered valid. Changing CS to low will start the PROGRAM operation. It is not necessary to make the data "1" before initiating the PROGRAM operation.



\*On the S-29590A, A<sub>10</sub> is optional.

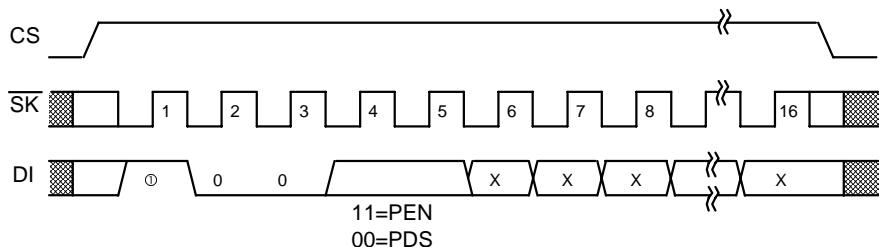
**Figure 5** Write Timing (S-29690A)

## **CMOS SERIAL E<sup>2</sup>PROM S-29590A / 29690A**

### **3. Write enable (PEN) and Write disable (PDS)**

The PEN instruction puts the S-29590A / 690A series into write enable mode, which accepts PROGRAM instructions. The PDS instruction puts the S-29590A / 690A series into write disable mode, which refuses PROGRAM instructions.

The S-29590A / 690A series powers on in write disable mode, which protects data against unexpected, erroneous write operations caused by noise and/or CPU malfunctions. It should be kept in write disable mode except when performing write operations.



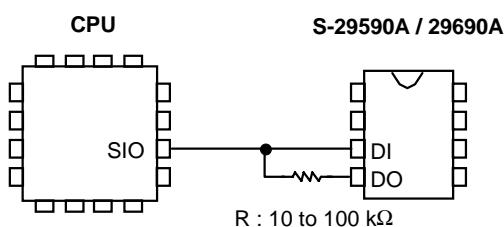
**Figure 6** PEN/PDS Timing (S-29690A)

### **■ Receiving a Start-Bit**

A start bit can be recognized by latching the high level of DI at the rising edge of  $\overline{\text{SK}}$  after changing CS to high (Start-bit Recognition). The write operation begins by inputting the write instruction and setting CS to low. The DO pin then outputs low during the write operation and high at its completion by setting CS to high (Verify Operation). Therefore, only after a write operation, in order to accept the next command by having CS go high, the DO pin switch from a state of high-impedance to a state of data output; but if it recognizes a start-bit, the DO pin returns to a state of high-impedance (see Figure 3).

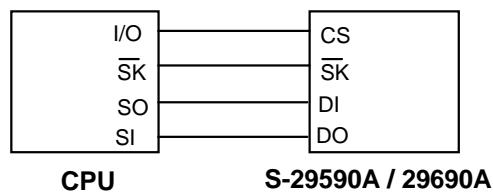
### **■ Three-wire Interface (DI-DO direct connection)**

Although the normal configuration of a serial interface is a 4-wire interface to CS,  $\overline{\text{SK}}$ , DI, and DO, a 3-wire interface is also a possibility by connecting DI and DO. However, since there is a possibility that the DO output from the serial memory IC will interfere with the data output from the CPU with a 3-wire interface, install a resistor between DI and DO in order to give preference to data output from the CPU to DI(See Figure 7).

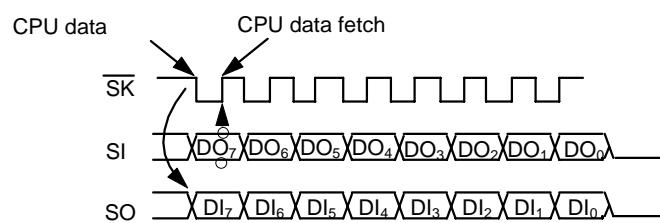


**Figure 7**

■ Connecting to the CPU with Serial Port



**Figure 9** Connection Example



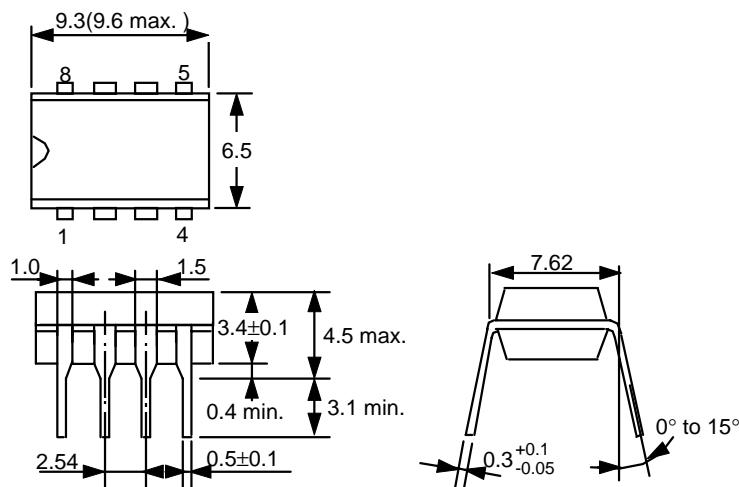
**Figure 10** Serial Shift Timing

# **CMOS SERIAL E<sup>2</sup>PROM**

## **S-29590A / 29690A**

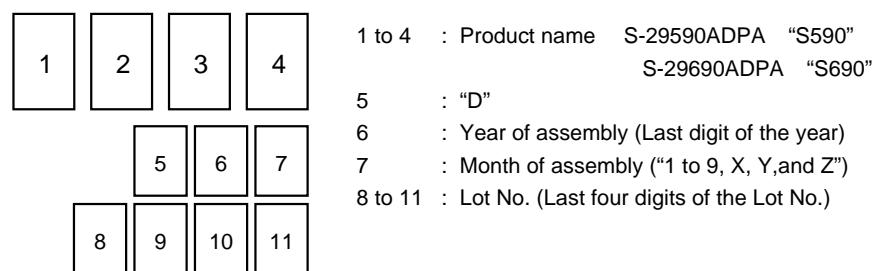
### **■ Dimensions (Unit : mm)**

#### **1. 8-pin DIP**



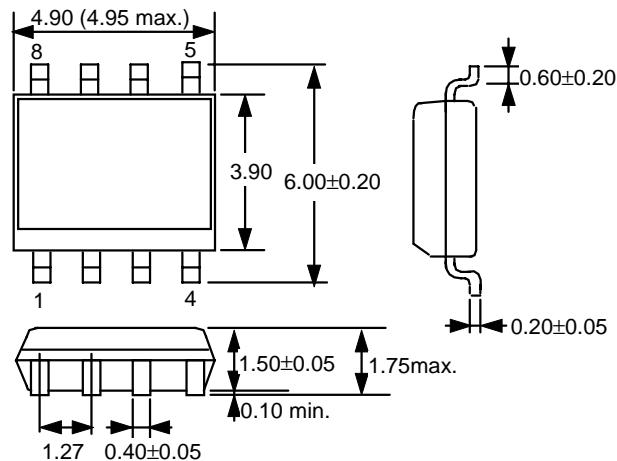
**Figure 10**

### **Markings**



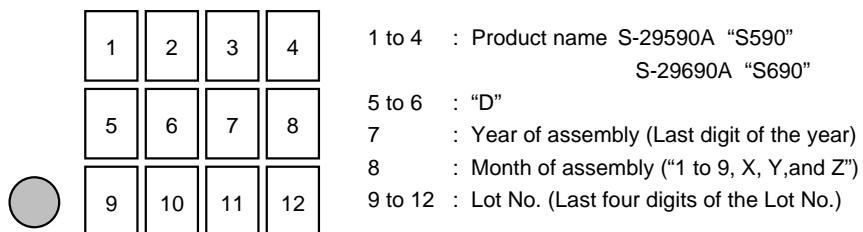
**Figure 11**

2. 8-pin SOP



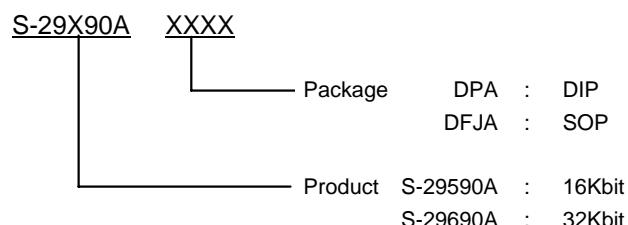
**Figure 12**

Markings



**Figure 13**

■ Ordering Information



# CMOS SERIAL E<sup>2</sup>PROM

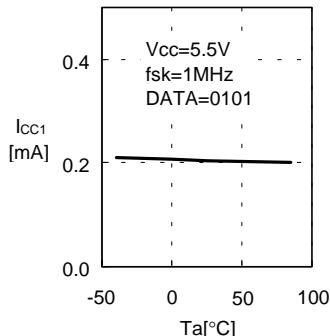
## S-29590A / 29690A

---

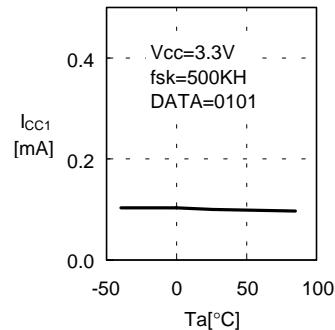
### ■ Characteristics

#### 1.DC Characteristics

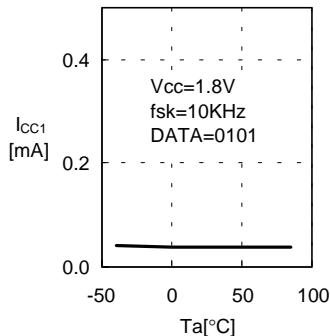
1.1 Current consumption (READ)  $I_{CC1}$  – Ambient temperature  $T_a$



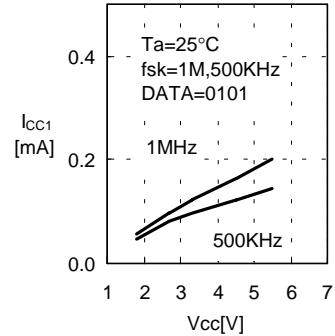
1.2 Current consumption (READ)  $I_{CC1}$  – Ambient temperature  $T_a$



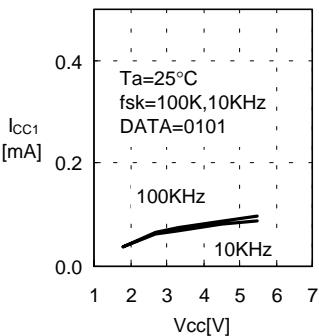
1.3 Current consumption (READ)  $I_{CC1}$  – Ambient temperature  $T_a$



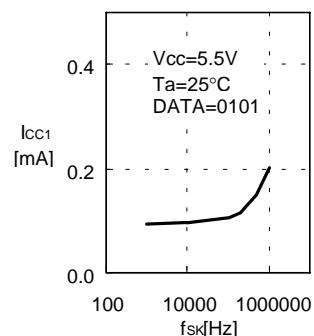
1.4 Current consumption (READ)  $I_{CC1}$  – Power supply voltage  $V_{CC}$



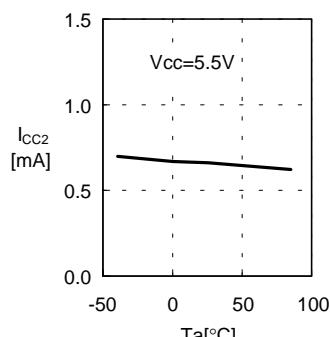
1.5 Current consumption (READ)  $I_{CC1}$  – Power supply voltage  $V_{CC}$



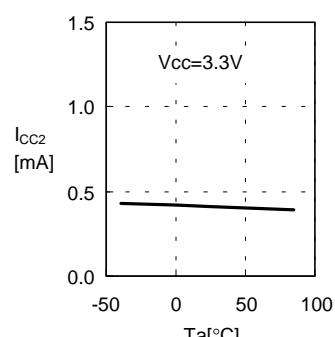
1.6 Current consumption (READ)  $I_{CC1}$  – Clock frequency  $f_{SK}$



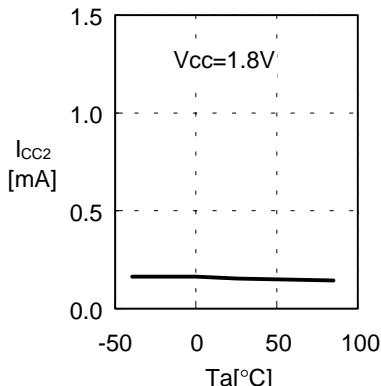
1.7 Current consumption (PROGRAM)  $I_{CC2}$  – Ambient temperature  $T_a$



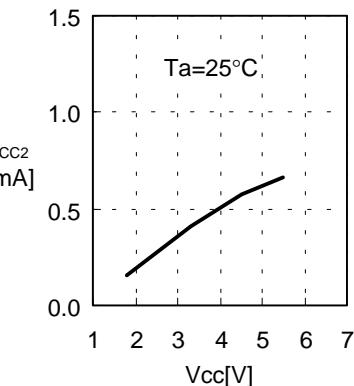
1.8 Current consumption (PROGRAM)  $I_{CC2}$  – Ambient temperature  $T_a$



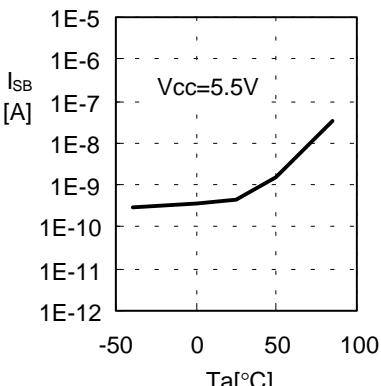
1.9 Current consumption (PROGRAM)  $I_{CC2}$  – Ambient temperature  $T_a$



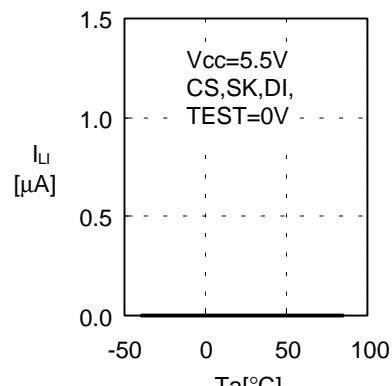
1.10 Current consumption (PROGRAM)  $I_{CC2}$  – Power supply voltage  $V_{CC}$



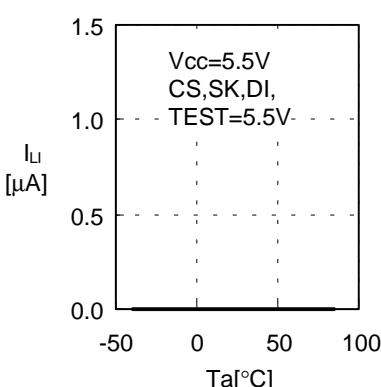
1.11 Standby current consumption  $I_{SB}$  – Ambient temperature  $T_a$



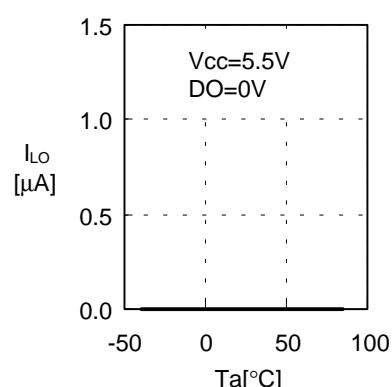
1.12 Input leakage current  $I_{LI}$  – Ambient temperature  $T_a$



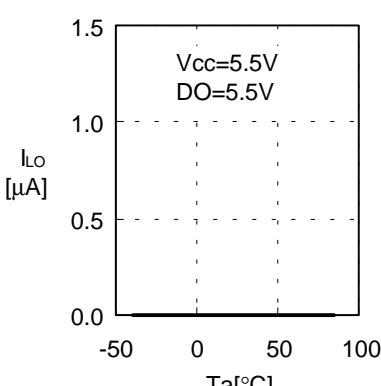
1.13 Input leakage current  $I_{LI}$  – Ambient temperature  $T_a$



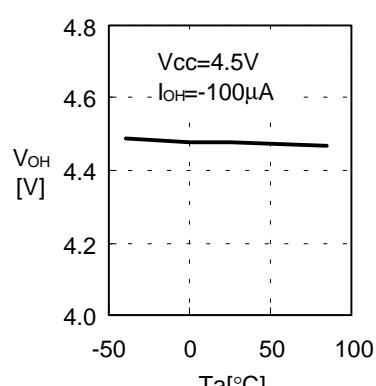
1.14 Output leakage current  $I_{LO}$  – Ambient temperature  $T_a$



1.15 Output leakage current  $I_{LO}$  – Ambient temperature  $T_a$



1.16 High level output voltage  $V_{OH}$  – Ambient temperature  $T_a$

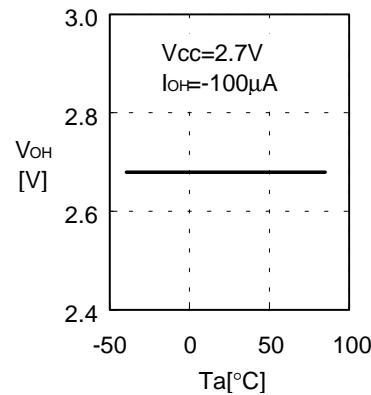


# CMOS SERIAL E<sup>2</sup>PROM

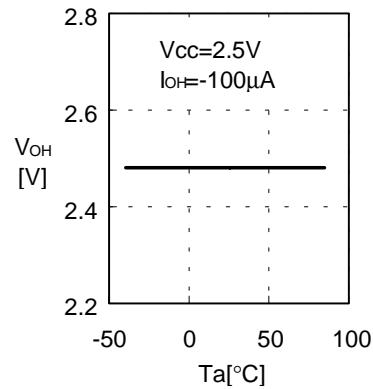
## S-29590A / 29690A

---

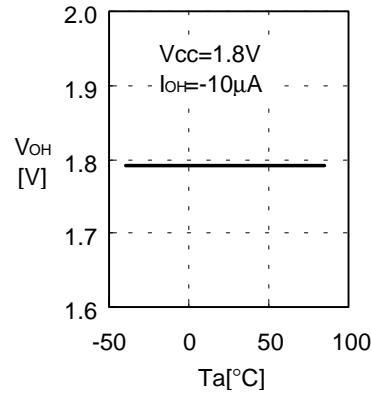
1.17 High level output voltage  $V_{OH}$  – Ambient temperature  $T_a$



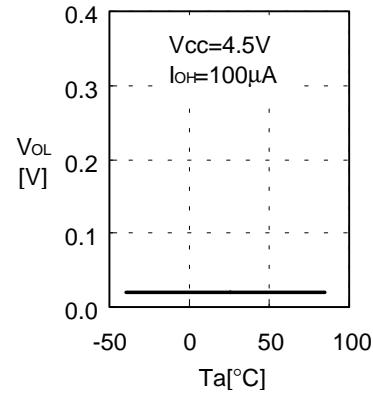
1.18 High level output voltage  $V_{OH}$  – Ambient temperature  $T_a$



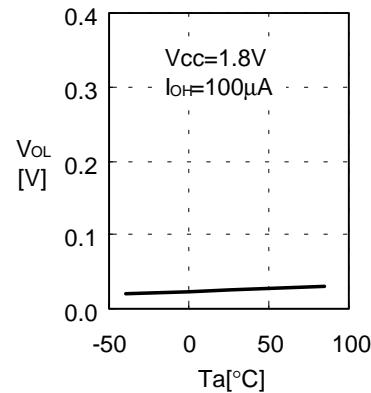
1.19 High level output voltage  $V_{OH}$  – Ambient temperature  $T_a$



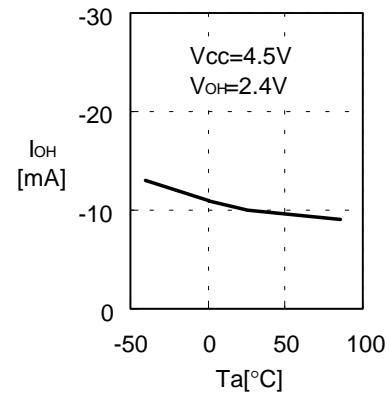
1.20 Low level output voltage  $V_{OL}$  – Ambient temperature  $T_a$



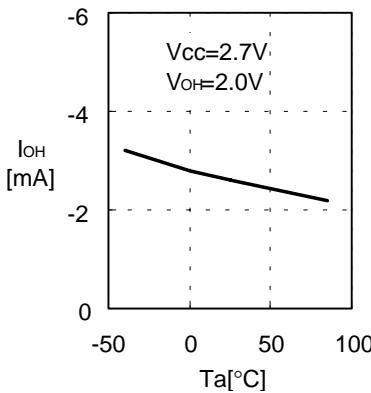
1.21 Low level output voltage  $V_{OL}$  – Ambient temperature  $T_a$



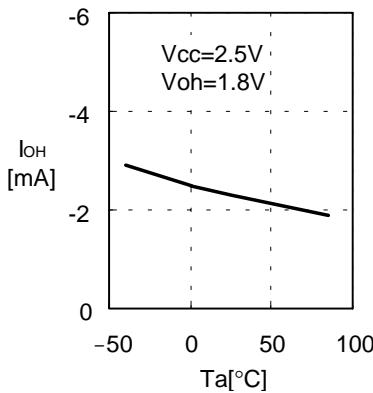
1.22 High level output current  $I_{OH}$  – Ambient temprature  $T_a$



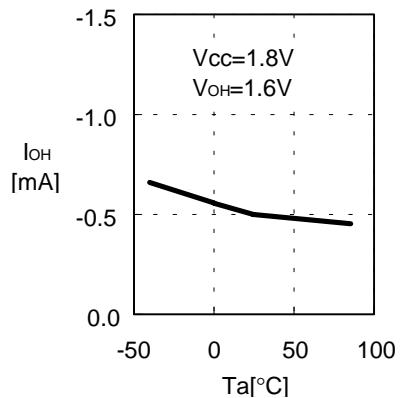
1.23 High level output current  $I_{OH}$  – Ambient temperature  $T_a$



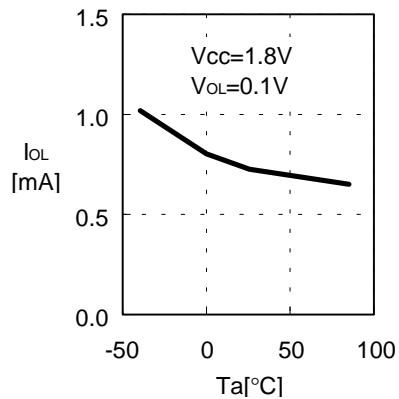
1.24 High level output current  $I_{OH}$  – Ambient temperature  $T_a$



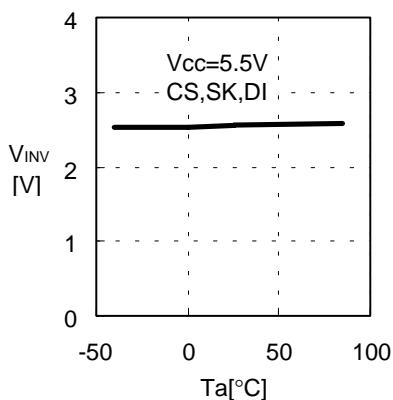
1.25 High level output current  $I_{OH}$  –  
Ambient temperature  $T_a$



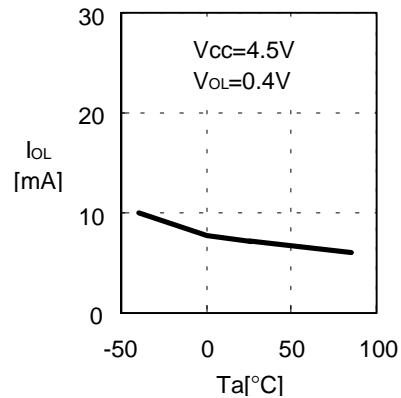
1.27 Low level output current  $I_{OL}$  –  
Ambient temperature  $T_a$



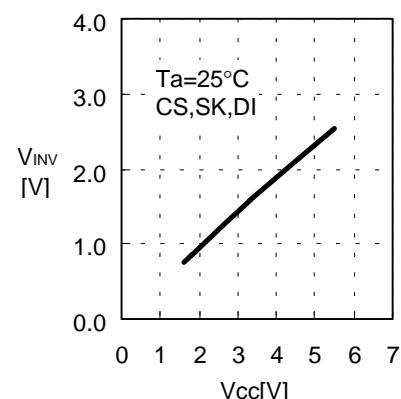
1.29 Input inversion voltage  $V_{INV}$  –  
Ambient temperature  $T_a$



1.26 Low level output current  $I_{OL}$  –  
Ambient temerature  $T_a$



1.28 Input inversion voltage  $V_{INV}$  –  
Power supply voltage  $V_{CC}$



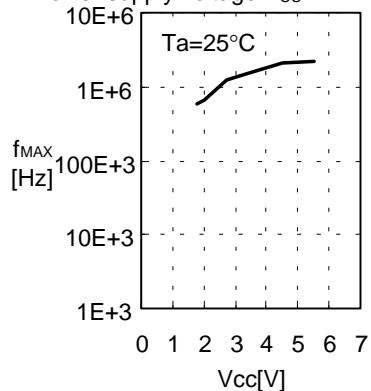
# CMOS SERIAL E<sup>2</sup>PROM

## S-29590A / 29690A

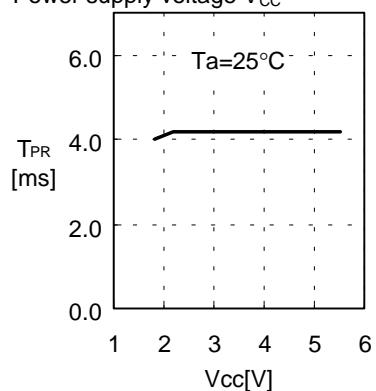
---

### 2.AC Characteristics

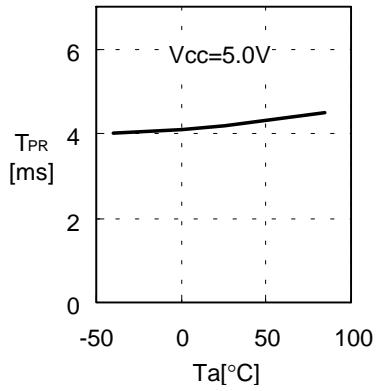
2.1 Maximum operation frequency  $f_{MAX}$  – Power supply voltage  $V_{CC}$



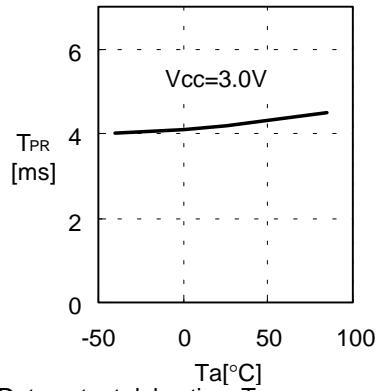
2.2 Program time  $T_{PR}$  – Power supply voltage  $V_{CC}$



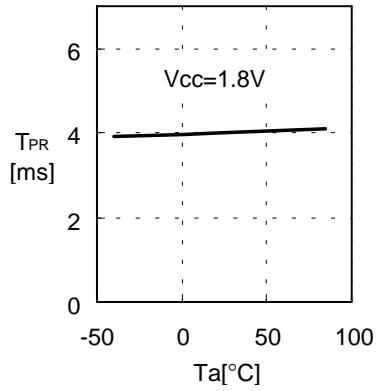
2.3 Program time  $T_{PR}$  – Ambient temperature  $T_a$



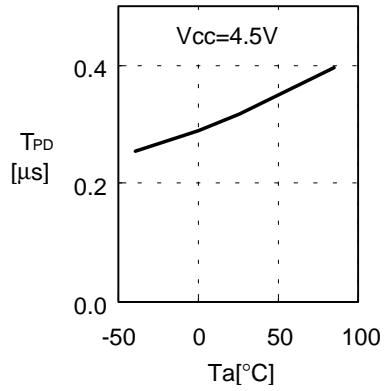
2.4 Program time  $T_{PR}$  – Ambient temperature  $T_a$



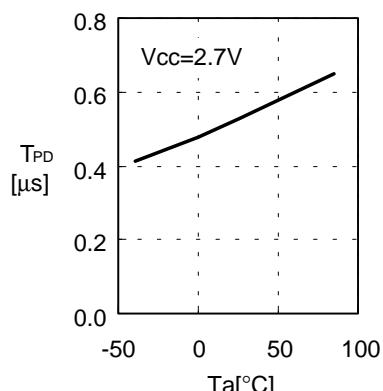
2.5 Program time  $T_{PR}$  – Ambient temperature  $T_a$



2.6 Data output delay time  $T_{PD}$  – Ambient temperature  $T_a$



2.7 Data output delay time  $T_{PD}$  – Ambient temperature  $T_a$



2.8 Data output delay time  $T_{PD}$  – Ambient temperature  $T_a$

